



N-Channel 12-V (D-S) MOSFET

| PRODUCT SUMMARY | | | |
|---------------------|----------------------------------|---------------------------------|----------------------|
| V _{DS} (V) | r _{DS(on)} (Ω) | I _D (A) ^e | Q _g (Typ) |
| 12 | 0.0037 @ V _{GS} = 4.5 V | 35 | 23 nC |
| | 0.007 @ V _{GS} = 2.5 V | 35 | |

FEATURES

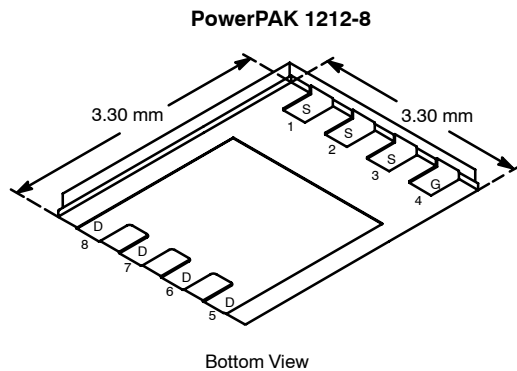
- TrenchFET® Power MOSFET
- Low Thermal Resistance PowerPAK® Package with Small Size and Low 1.07mm Profile
- 100% R_g Tested



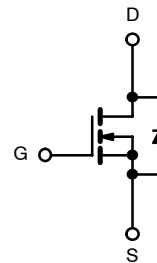
RoHS COMPLIANT

APPLICATIONS

- Synchronous Rectification
- Point-of-Load



Ordering Information: Si7104DN-T1—E3 (Lead (Pb)-Free)



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C UNLESS OTHERWISE NOTED) | | | |
|--|-----------------------------------|------------------------|---------------------|
| Parameter | Symbol | Limit | Unit |
| Drain-Source Voltage | V _{DS} | 12 | V |
| Gate-Source Voltage | V _{GS} | ± 12 | |
| Continuous Drain Current (T _J = 150 °C) | I _D | T _C = 25 °C | A |
| | | T _C = 70 °C | |
| | | T _A = 25 °C | |
| | | T _A = 70 °C | |
| Pulsed Drain Current | I _{DM} | 60 | |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | 3.2 ^{a, b} |
| | | T _A = 25 °C | |
| Maximum Power Dissipation | P _D | T _C = 25 °C | W |
| | | T _C = 70 °C | |
| | | T _A = 25 °C | |
| | | T _A = 70 °C | |
| Operating Junction and Storage Temperature Range | T _J , T _{stg} | -50 to 150 | °C |
| Soldering Recommendations (Peak Temperature) ^{c, d} | | 260 | |

Notes:

- Surface Mounted on 1" x 1" FR4 Board.
- t = 10 sec
- See Solder Profile (<http://www.vishay.com/doc?73257>). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Package limited.

| THERMAL RESISTANCE RATINGS | | | | | |
|---|-----------------|------------|---------|---------|------|
| Parameter | | Symbol | Typical | Maximum | Unit |
| Maximum Junction-to-Ambient ^{a, b} | $t \leq 10$ sec | R_{thJA} | 24 | 33 | °C/W |
| Maximum Junction-to-Case (Drain) | Steady State | R_{thJC} | 1.9 | 2.4 | |

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
 b. Maximum under steady state conditions is 81 °C/W.

| SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED) | | | | | | |
|---|-------------------------|--|-----|--------|-----------|---------------|
| Parameter | Symbol | Test Condition | Min | Typ | Max | Unit |
| Static | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$ | 12 | | | V |
| V_{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | $I_D = 250\ \mu\text{A}$ | | 8 | | mV/°C |
| $V_{GS(th)}$ Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | | | -4.5 | | |
| Gate-Source Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$ | 0.6 | | 1.8 | V |
| Gate-Source Leakage | I_{GSS} | $V_{DS} = 0\text{ V}, V_{GS} = \pm 12\text{ V}$ | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 12\text{ V}, V_{GS} = 0\text{ V}$ | | | 1 | μA |
| | | $V_{DS} = 12\text{ V}, V_{GS} = 0\text{ V}, T_J = 55^\circ\text{C}$ | | | 10 | |
| On-State Drain Current ^a | $I_{D(on)}$ | $V_{DS} \geq 5\text{ V}, V_{GS} = 4.5\text{ V}$ | 40 | | | A |
| Drain-Source On-State Resistance ^a | $r_{DS(on)}$ | $V_{GS} = 4.5\text{ V}, I_D = 26.1\text{ A}$ | | 0.0031 | 0.0037 | Ω |
| | | $V_{GS} = 2.5\text{ V}, I_D = 19\text{ A}$ | | 0.0057 | 0.007 | |
| Forward Transconductance ^a | g_{fs} | $V_{DS} = 15\text{ V}, I_D = 26.1\text{ A}$ | | 90 | | S |
| Dynamic^b | | | | | | |
| Input Capacitance | C_{iss} | $V_{DS} = 6\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$ | | 2800 | | pF |
| Output Capacitance | C_{oss} | | | 1050 | | |
| Reverse Transfer Capacitance | C_{rss} | | | 520 | | |
| Total Gate Charge | Q_g | $V_{DS} = 6\text{ V}, V_{GS} = 10\text{ V}, I_D = 26.1\text{ A}$ | | 46 | 70 | nC |
| | | $V_{DS} = 6\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 26.1\text{ A}$ | | 23 | 35 | |
| Gate-Source Charge | Q_{gs} | $V_{DS} = 6\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 26.1\text{ A}$ | | 5.3 | | |
| Gate-Drain Charge | Q_{gd} | | | 5.1 | | |
| Gate Resistance | R_g | $f = 1\text{ MHz}$ | 0.6 | 1.2 | 1.8 | Ω |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = 6\text{ V}, R_L = 0.6\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\ \Omega$ | | 20 | 30 | ns |
| Rise Time | t_r | | | 20 | 30 | |
| Turn-Off Delay Time | $t_{d(off)}$ | | | 33 | 50 | |
| Fall Time | t_f | | | 10 | 15 | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = 6\text{ V}, R_L = 0.6\ \Omega$ $I_D \cong 10\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\ \Omega$ | | 12 | 20 | ns |
| Rise Time | t_r | | | 11 | 20 | |
| Turn-Off Delay Time | $t_{d(off)}$ | | | 36 | 55 | |
| Fall Time | t_f | | | 10 | 15 | |



| SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED) | | | | | | |
|---|----------|---|-----|-----|-----|------|
| Parameter | Symbol | Test Condition | Min | Typ | Max | Unit |
| Drain-Source Body Diode Characteristics | | | | | | |
| Continuous Source-Drain Diode Current | I_S | $T_C = 25^\circ\text{C}$ | | | 35 | A |
| Pulse Diode Forward Current ^a | I_{SM} | | | | 60 | |
| Body Diode Voltage | V_{SD} | $I_S = 3.2\text{ A}$ | | 0.8 | 1.2 | V |
| Body Diode Reverse Recovery Time | t_{rr} | $I_F = 10\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$ | | 80 | 50 | ns |
| Body Diode Reverse Recovery Charge | Q_{rr} | | | 49 | 75 | nC |
| Reverse Recovery Fall Time | t_a | | | | 20 | ns |
| Reverse Recovery Rise Time | t_b | | | | 60 | |

Notes

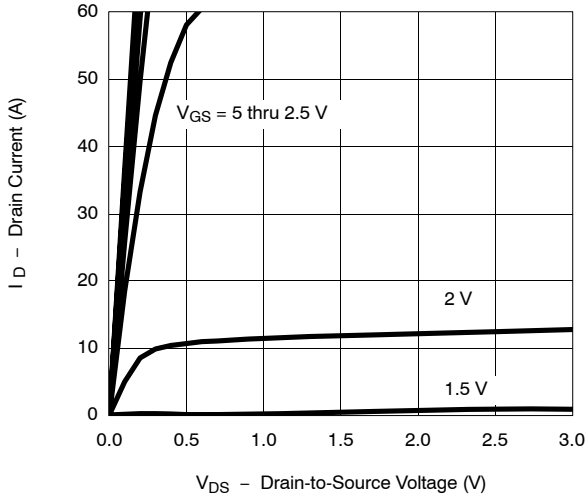
- Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.
- Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

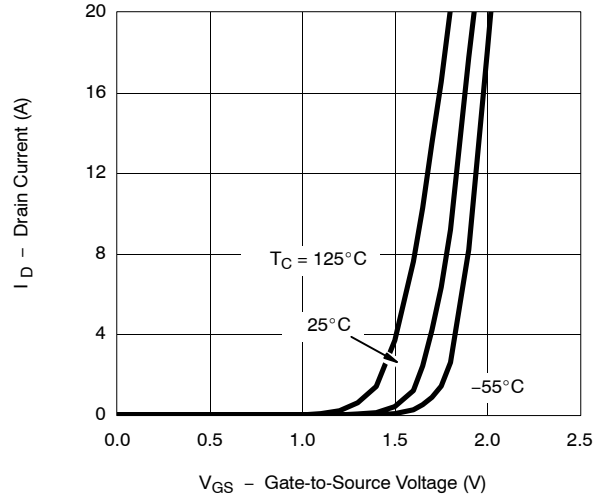


TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

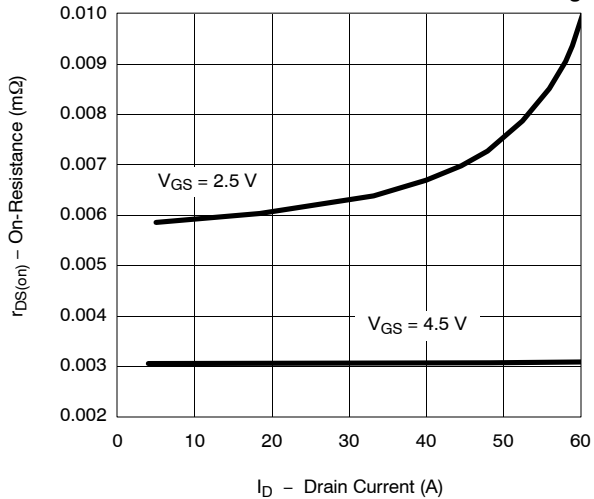
Output Characteristics



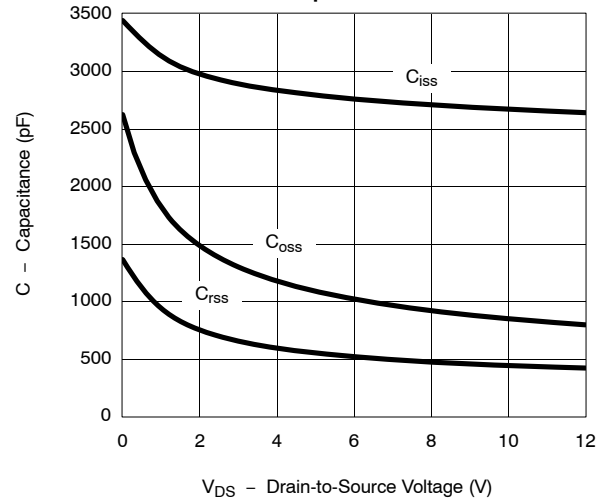
Transfer Characteristics



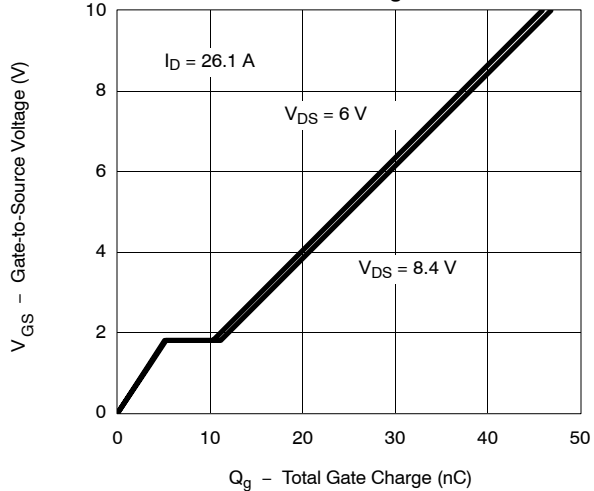
On-Resistance vs. Drain Current and Gate Voltage



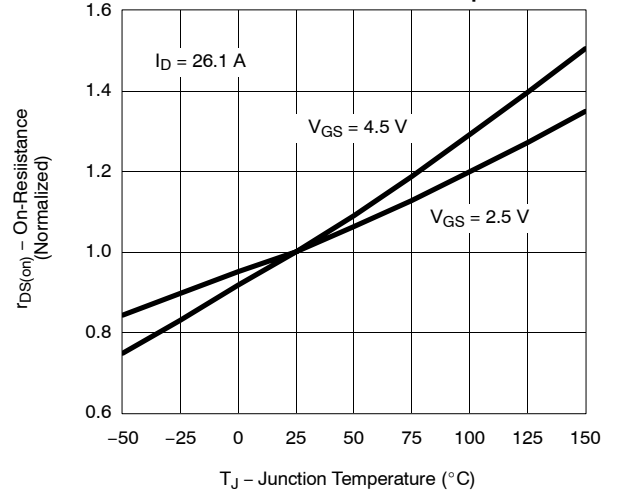
Capacitance



Gate Charge



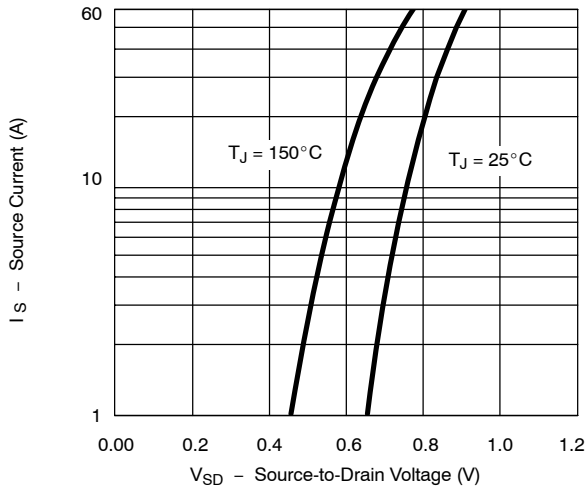
On-Resistance vs. Junction Temperature



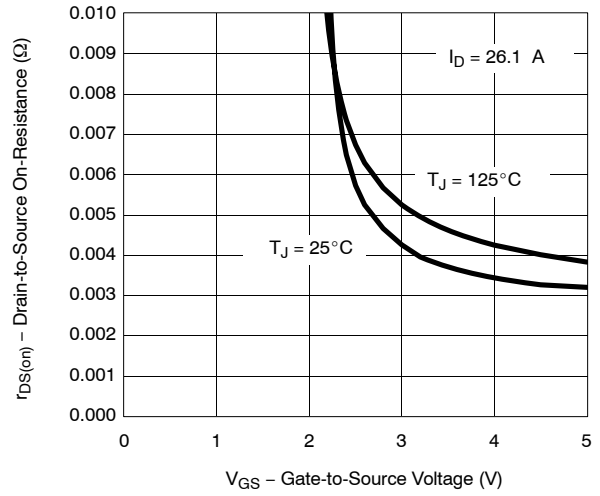


TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

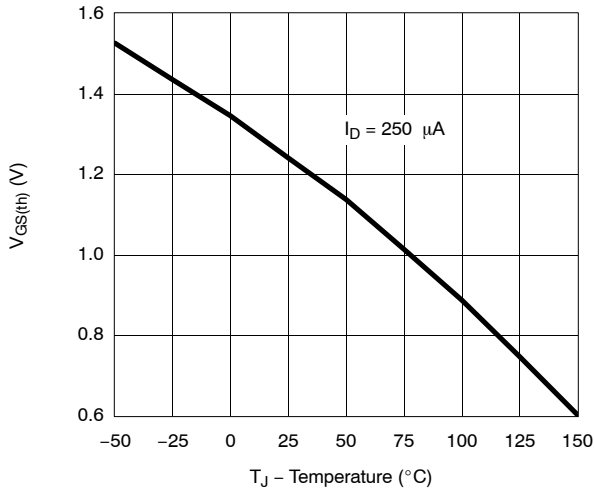
Source-Drain Diode Forward Voltage



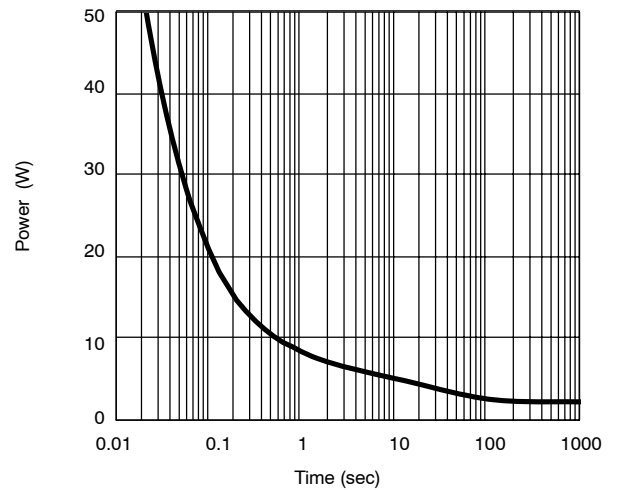
On-Resistance vs. Gate-to-Source Voltage



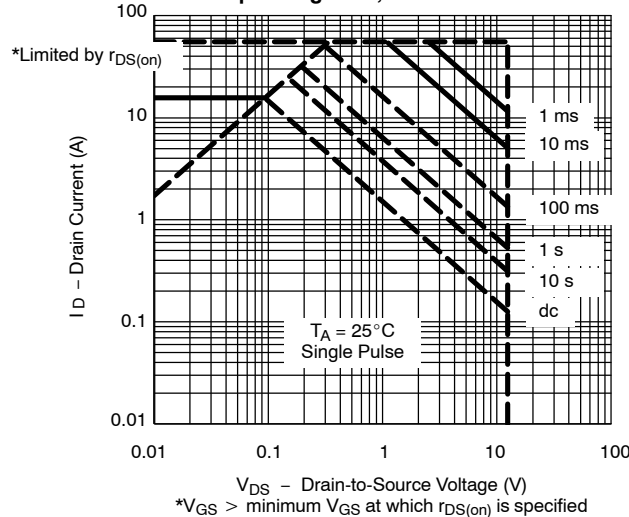
Threshold Voltage



Single Pulse Power, Junction-to-Ambient

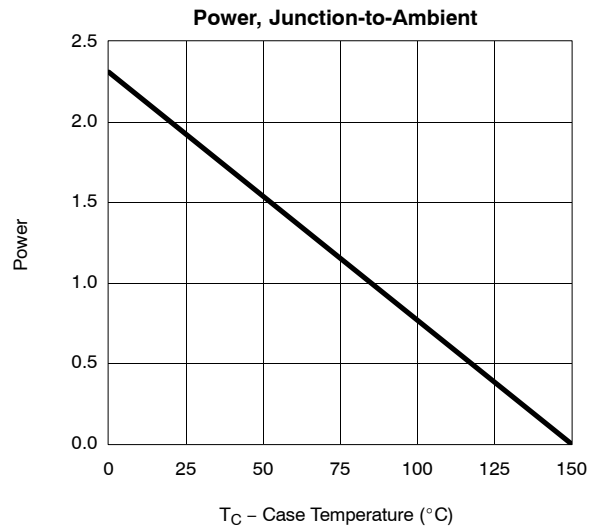
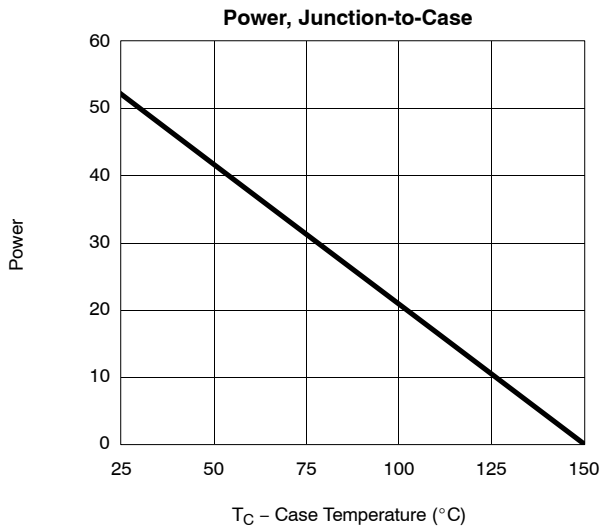
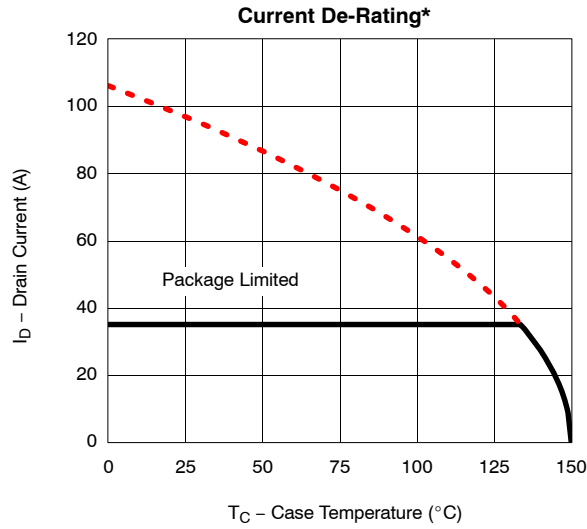


Safe Operating Area, Junction-to-Ambient





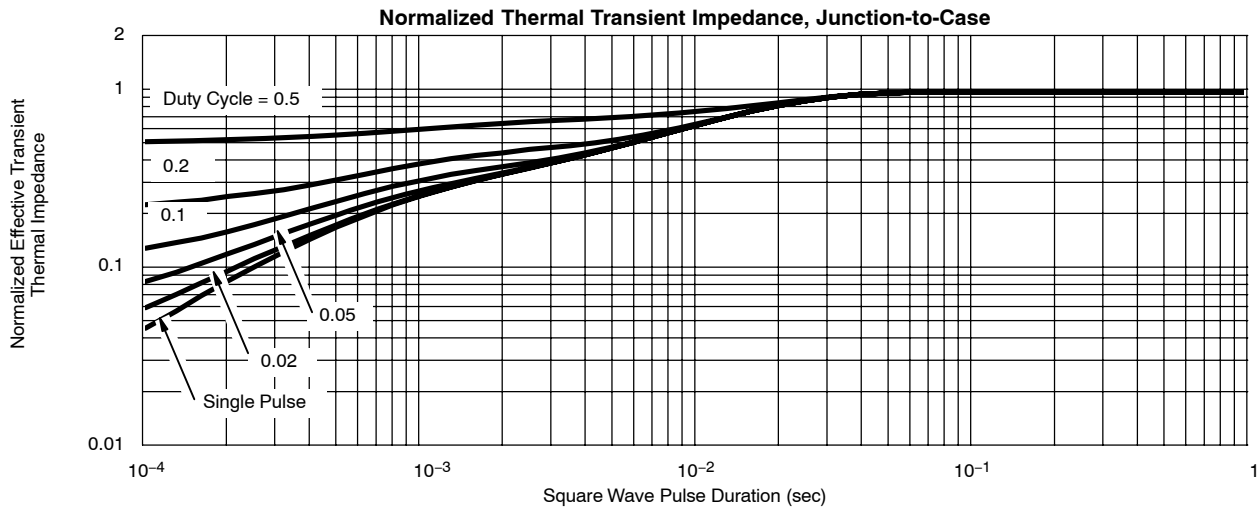
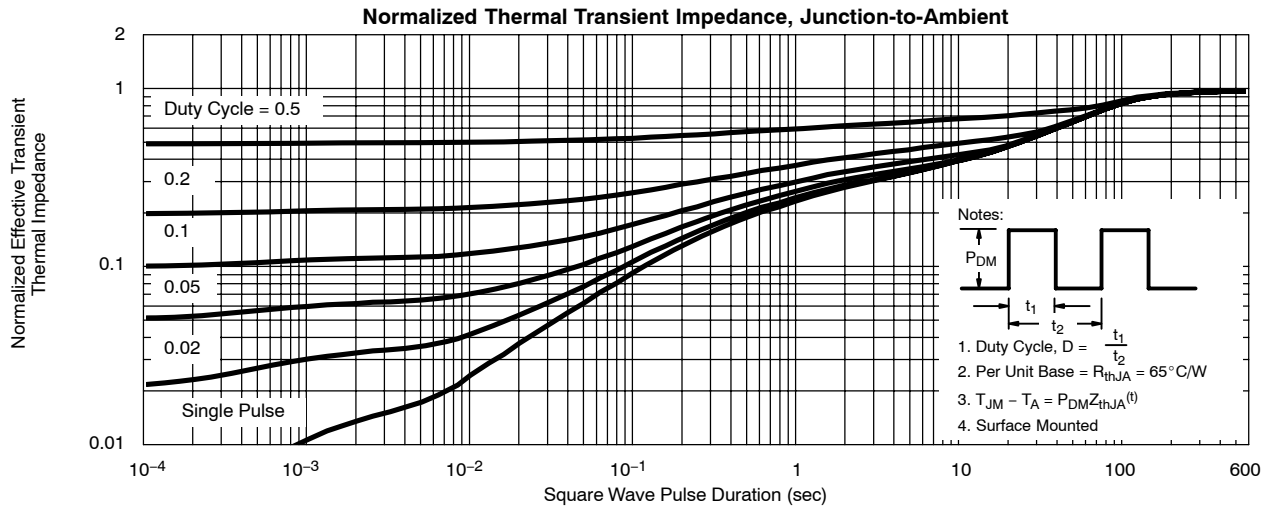
TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)



*The power dissipation P_D is based on $T_{J(max)} = 150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)



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